

Notice of References Cited	Application/Control No. 10/517,213	Applicant(s)/Patent Under Reexamination YAMANE, MITOKU	
	Examiner Quoc A. Tran	Art Unit 2176	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0063070 A1	04-2003	Kang, Beng Hong Alex	345/168
*	B	US-6,541,715 B2	04-2003	Swanson, Philip	200/5A
*	C	US-2002/0045463 A1	04-2002	Chen et al.	455/566
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
	R					
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	T					

NON-PATENT DOCUMENTS

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	V	
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	X	

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